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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/001,756	BECK	
Examiner	Art Unit	•
John S. Chu	1752	

SEARCHED				
Class	Subclass	Date	Examiner	
430	270.1	a/2016	Dec	
548	440	1		
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INTERFERENCE SEARCHED			
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430	270.1	9/2006 Jee	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/001,756	BECK	
Examiner	Art Unit	_
John S. Chu	1752	

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